

MOSFET - P-Channel, QFET

-400 V, -1.56 A, 6.5 Ω

FQD2P40

Description

This P-Channel enhancement mode power MOSFET is produced using **onsemi**'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

Features

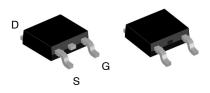
- -1.56 A, -400 V, $R_{DS(on)} = 6.5$ Ω (Max.) @ $V_{GS} = -10$ V, $I_D = -0.78$ A
- Low Gate Charge (Typ. 10 nC)
- Low Crss (Typ. 6.5 pF)
- 100% Avalanche Tested
- RoHS Compliant

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

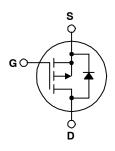
Symbol	Parameter	Value	Unit	
V _{DSS}	Drain-Source Voltage	-400	V	
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)	-1.56 -0.98	А	
I _{DM}	Drain Current - Pulsed (Note 1)	-6.24	Α	
V _{GSS}	Gate-Source Voltage	±30	V	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)	120	mJ	
I _{AR}	Avalanche Current (Note1)	-1.56	Α	
E _{AR}	Repetitive Avalanche Energy (Note 1)	3.8	mJ	
dv/dt	Peak Diode Recovery dv/dt (Note 3)	-4.5	V/ns	
P_{D}	Power Dissipation (T _A = 25°C)*	2.5	W	
	Power Dissipation (T _C = 25°C) – Derate above 25°C	38 0.3	W W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range	–55 to +150	°C	
T_L	T _L Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

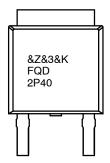
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DPAK3 CASE 369AS



MARKING DIAGRAM



&Z = Assembly Code

&3 = Date Code (Year and Week)

&K = Lot Code

FQD2P40 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping [†]
FQD2P40TM	DPAK3 (Pb-Free)	2,500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
Rejc	Thermal Resistance, Junction to Case, Max.	3.29	°C/W
RеJA	Thermal Resistance, Junction to Ambient (Minimum Pad of 2-oz Copper), Max.	110	°C/W
Reja	Thermal Resistance, Junction to Ambient (*1 in2 Pad of 2-oz Copper), Max.	50	°C/W

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

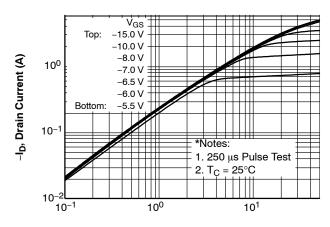
Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
OFF CHARAC	CTERISTICS			•	•	
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-400	-	-	V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu A$, Referenced to 25°C	-	-	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -400 \text{ V}, V_{GS} = 0 \text{ V}$	_	-	-1	μΑ
		$V_{DS} = -320 \text{ V}, T_{C} = 125^{\circ}\text{C}$	-	-	-10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	-100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = 30 V, V _{DS} = 0 V	_	-	100	nA
ON CHARAC	TERISTICS					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-3.0	-	-5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V}, I_D = -0.78 \text{ A}$	-	5.0	6.5	Ω
9FS	Forward Transconductance	$V_{DS} = -50 \text{ V}, I_D = -0.78 \text{ A}$	-	1.26	-	S
DYNAMIC CH	ARACTERISTICS			•		
C _{iss}	Input Capacitance	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$	_	270	350	pF
C _{oss}	Output Capacitance	f = 1.0 MHz	_	45	60	pF
C _{rss}	Reverse Transfer Capacitance		-	6.5	8.5	pF
SWITCHING (CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -200 \text{ V}, I_D = -2.0 \text{ A},$	-	9	30	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$ (Note 4)	-	33	75	ns
t _{d(off)}	Turn-Off Delay Time]	-	22	55	ns
t _f	Turn-Off Fall Time]	-	25	60	ns
Q_g	Total Gate Charge	$V_{DS} = -320 \text{ V}, I_D = -2.0 \text{ A},$	-	10	13	nC
Q_{gs}	Gate-Source Charge	V _{GS} = −10 V (Note 4)	-	2.1	-	nC
Q_{gd}	Gate-Drain Charge	,	-	5.5	-	nC
DRAIN-SOUF	RCE DIODE CHARACTERISTICS AND N	MAXIMUM RATINGS				
I _S	Maximum Continuous Drain-Source Diode Forward Current		-	-	-1.56	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		-	-	-6.24	Α
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -1.56 \text{ A}$	-	-	-5.0	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V, } I_{S} = -2.0 \text{ A,}$	-	250	_	ns
Q _{rr}	Reverse Recovery Charge	dl _F / dt = 100 A/ μs	_	0.85	-	μС

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 1. Repetitive Rating: Pulse–width limited by maximum junction temperature.
 2. L = 86 mH, I_{AS} = -1.56 A, V_{DD} = -50 V, R_G = 25 Ω , Starting T_J = 25°C.
 3. I_{SD} \leq -2.0 A, di/dt \leq 200 A/ μ s, V_{DD} \leq BV_{DSS}, Starting T_J = 25°C.
 4. Essentially independent of operating temperature.

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TYPICAL CHARACTERISTICS



-V_{DS}, Drain-Source Voltage (V)

Figure 1. On-Region Characteristics

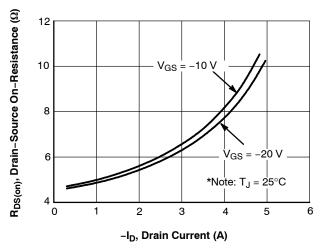


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

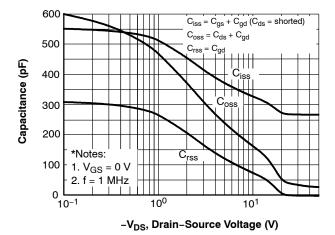
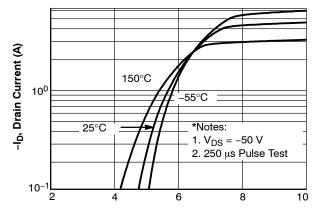


Figure 5. Capacitance Characteristics



-V_{GS}, Gate-Source Voltage (V)

Figure 2. Transfer Characteristics

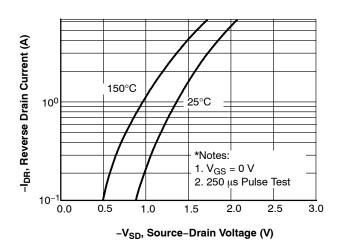


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

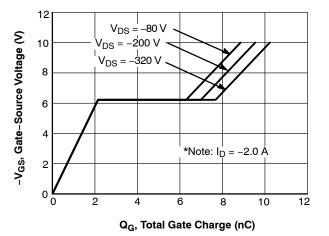
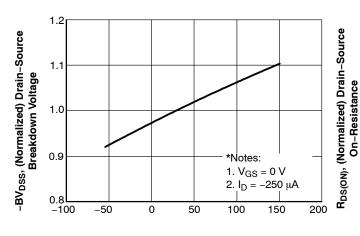


Figure 6. Gate Charge Characteristics

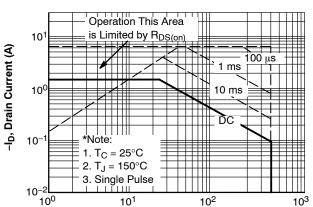
TYPICAL CHARACTERISTICS (continued)



2.5 2.0 1.5 1.0 0.5 1. V_{GS} = -10 V 2. I_D = -1.0 A 0.0 -100 -50 0 50 100 150 200

T_J, Junction Temperature (°C)

Figure 7. Breakdown Voltage Variation vs. Temperature



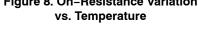
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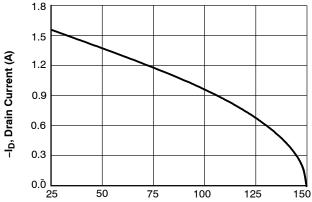
Figure 9. Maximum Safe Operating Area

-V_{DS}, Drain-Source Voltage (V)

Figure 8. On-Resistance Variation

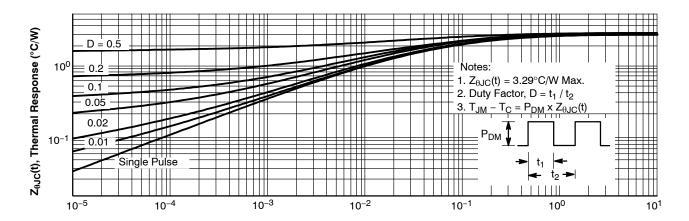
T_J, Junction Temperature (°C)





T_C, Case Temperature (°C)

Figure 10. Maximum Drain Current vs. Case Temperature



t₁, Square Wave Pulse Duration (s)

Figure 11. Transient Thermal Response Curve

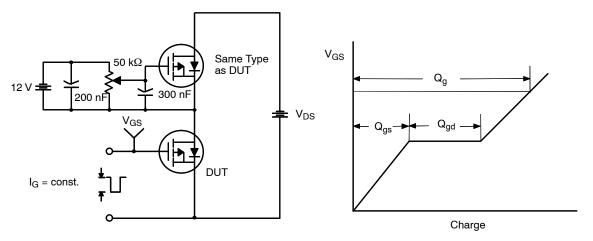


Figure 12. Gate Charge Test Circuit & Waveform

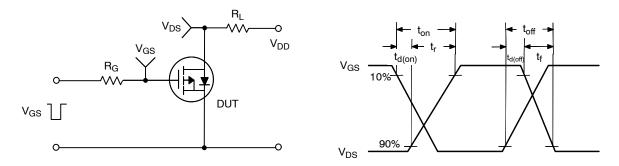


Figure 13. Resistive Switching Test Circuit & Waveforms

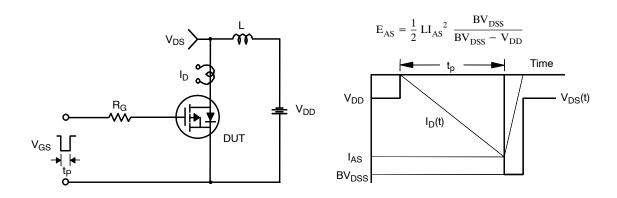
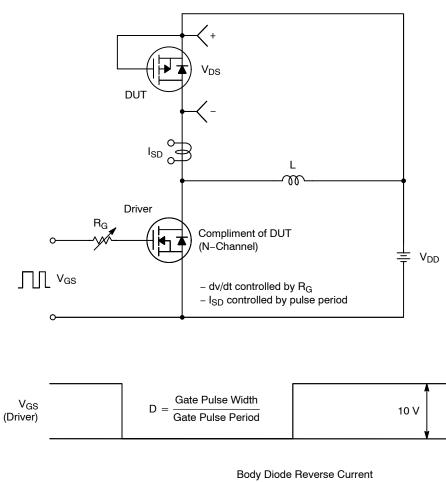
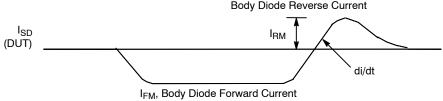


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

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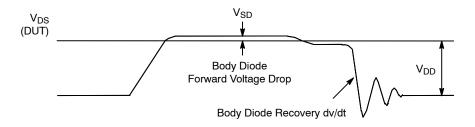


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms





DPAK3 6.10x6.54x2.29, 4.57P CASE 369AS **ISSUE B**

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DATE 20 DEC 2023

- NOTES: UNLESS OTHERWISE SPECIFIED

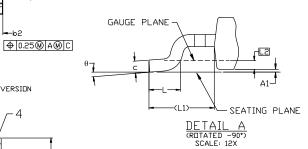
 A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE F, VARIATION AA.

 B) ALL DIMENSIONS ARE IN MILLIMETERS.

 C) DIMENSIONING AND TOLERANCING PER

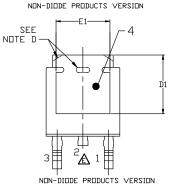
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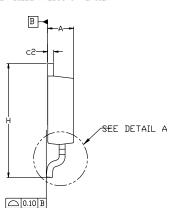
- F)
- DIMENSIONING AND TOLERANCING PER
 ASME Y14.5M-2018.
 SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED
 CORNERS OR EDGE PROTRUSION.
 FOR DIGDE PRODUCTS, L4 IS 0.25 MM MAX PLASTIC BODY
 STUB WITHOUT CENTER LEAD.
 DIMENSIONS ARE EXCLUSIVE OF BURRS,
 MOLD FLASH AND TIE BAR EXTRUSIONS.
 LAND PATTERN RECOMMENDATION IS BASED ON IPC7351A STD
 T0228P991X239-3N.

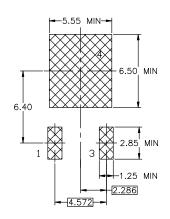


DIM	MILLIMETERS			
Din	MIN.	N□M.	MAX.	
Α	2.18	2.29	2.39	
A1	0.00	-	0.127	
b	0.64	0.77	0.89	
b2	0.76	0.95	1.14	
b3	5.21	5.34	5.46	
C	0.45	0.53	0.61	
c2	0.45	0.52	0.58	
D	5.97	6.10	6.22	
D1	5.21			
Ε	6.35	6.54	6.73	
E1	4.32			
е	2.286 BSC			
e1	4.572 BSC			
Н	9.40	9.91	10.41	
L	1.40	1.59	1.78	
L1	2.90 REF			
L2	0.51 BSC			
L3	0.89	1.08	1.27	
L4			1.02	
θ	0°		10°	

MILLIMETERS







LAND PATTERN RECOMMENDATION

*FOR ADDITIONAL INFORMATION ON DUR
PB-FREE STRATEGY AND SOLDERING DETAILS,
PLEASE DOWNLOAD THE ON SEMICONDUCTOR
SOLDERING AND MOUNTING TECHNIQUES
REFERENCE MANUAL, SOLDERRM/D.

GENERIC MARKING DIAGRAM*

XXXXXX XXXXXX **AYWWZZ**

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "=", may or may not be present. Some products may not follow the Generic Marking.

XXXX = Specific Device Code

= Assembly Location Α

Υ = Year

WW = Work Week

77 = Assembly Lot Code

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